

Not for New Design

The ACS716 is in production but has been determined to be NOT FOR NEW DESIGN. This classification indicates that sale of this device is currently restricted to existing customer applications. The device should not be purchased for new design applications because obsolescence in the near future is probable. Samples are no longer available.

Date of status change: March 14, 2025

Recommended Substitutions:

For existing customer transition, and for new customers or new applications, refer to ACS37002 (recommended for its high accuracy and included features) or ACS720.

NOTE: For detailed information on purchasing options, contact your local Allegro field applications engineer or sales representative.

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FEATURES AND BENEFITS

- Industry-leading noise performance with greatly improved bandwidth through proprietary amplifier and filter design techniques
- Small footprint package suitable for space-constrained applications
- 1 m Ω primary conductor resistance for low power loss
- High isolation voltage, suitable for line-powered applications
- User-adjustable Overcurrent Fault level
- Overcurrent Fault signal typically responds to an overcurrent condition in < 2 μs
- Integrated shield virtually eliminates capacitive coupling from current conductor to die due to high dV/dt voltage transients
- Filter pin capacitor improves resolution in low bandwidth applications
- 3 to 3.6 V single supply operation
- Factory-trimmed sensitivity and quiescent output voltage
- Chopper stabilization results in extremely stable quiescent output voltage
- Ratiometric output from supply voltage



PACKAGE:

16-Pin SOIC Hall Effect IC Package (suffix LA)



Not to scale

DESCRIPTION

The Allegro[™] ACS716 current sensor provides economical and precise means for current sensing applications in industrial, commercial, and communications systems. The device is offered in a small footprint surface-mount package that allows easy implementation in customer applications.

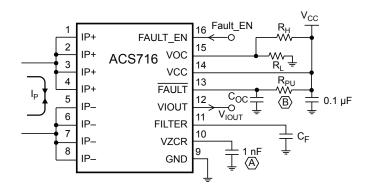
The ACS716 consists of a precision linear Hall sensor integrated circuit with a copper conduction path located near the surface of the silicon die. Applied current flows through the copper conduction path, and the analog output voltage from the Hall sensor linearly tracks the magnetic field generated by the applied current. The accuracy of the ACS716 is maximized with this patented packaging configuration because the Hall element is situated in extremely close proximity to the current to be measured.

High-level immunity to current conductor dV/dt and stray electric fields, offered by Allegro proprietary integrated shield technology, results in low ripple on the output and low offset drift in high-side, high-voltage applications.

The voltage on the Overcurrent Input (VOC pin) allows customers to define an overcurrent fault threshold for the device. When the current flowing through the copper conduction path (between the IP+ and IP- pins) exceeds this threshold, the open drain Overcurrent Fault pin will transition to a logic low state. Factory programming of the linear Hall sensor inside of the ACS716 results in exceptional accuracy in both analog and digital output signals.

The internal resistance of the copper path used for current sensing is typically 1 m Ω , for low power loss. Also, the current conduction path is electrically isolated from the low-voltage

Continued on the next page...



R_H, R_L	Sets resistor divider reference for V _{OC}
C_F	Noise and bandwidth limiting filter capacitor
C_{OC}	Fault delay setting capacitor, 22 nF maximum
$\langle A \rangle$	Use of capacitor required
B	Use of resistor optional, 330 k Ω recommended. If used, resistor must be connected between $\overline{EAL} \parallel T$ nin and V_{aa}

120 kHz Bandwidth, High-Voltage Isolation Current Sensor with Integrated Overcurrent Detection

DESCRIPTION (continued)

sensor inputs and outputs. This allows the ACS716 family of sensors to be used in applications requiring electrical isolation, without the use of opto-isolators or other costly isolation techniques.

The ACS716 is provided in a small, surface-mount SOIC16 package. The leadframe is plated with 100% matte tin, which is compatible with standard lead (Pb) free printed circuit board assembly processes. Internally, the device is Pb-free, except for flip-chip high-temperature

Pb-based solder balls, currently exempt from RoHS. The device is fully calibrated prior to shipment from the factory.

Applications include:

- Motor control and protection
- · Load management and overcurrent detection
- Power conversion and battery monitoring / UPS systems

SELECTION GUIDE

Part Number	I _P (A)	Sens (typ) at V _{CC} = 3.3 V (mV/A)	Latched Fault	T _A (°C)	Packing ^[1]		
ACS716KLATR-6BB-T [2]	±6	100	Yes				
ACS716KLATR-12CB-T ^[2]	±12.5	37	Yes				
ACS716KLATR-25CB-T [2]	±25	18.5	Yes	40 4- 405	40 to 405	40 to 125	Tana and Daal 1000 pieces per real
ACS716KLATR-6BB-NL-T [2]	±6	100	No	-40 to 125	Tape and Reel, 1000 pieces per reel		
ACS716KLATR-12CB-NL-T [2]	±12.5	37	No				
ACS716KLATR-25CB-NL-T [2]	±25	18.5	No				

^[1] Contact Allegro for packing options.



^[2] Variant not intended for automotive applications.

120 kHz Bandwidth, High-Voltage Isolation Current Sensor with Integrated Overcurrent Detection

ABSOLUTE MAXIMUM RATINGS

Characteristic	Symbol	Notes	Rating	Units
Supply Voltage	V _{CC}		8	V
Filter Pin	V _{FILTER}		8	V
Analog Output Pin	V _{IOUT}		32	V
Overcurrent Input Pin	V _{oc}		8	V
Overcurrent FAULT Pin	V _{FAULT}		8	V
Fault Enable (FAULT_EN) Pin	V _{FAULTEN}		8	V
Voltage Reference Output Pin	V _{ZCR}		8	V
DC Reverse Voltage: VCC, FILTER, VIOUT, VOC, FAULT, FAULT_EN, and VZCR Pins	V _{Rdcx}		-0.5	V
Excess to Supply Voltage: FILTER, VIOUT, VOC, FAULT, FAULT_EN, and VZCR Pins	V _{EX}	Voltage by which pin voltage can exceed the VCC pin voltage	0.3	V
Output Current Source	I _{IOUT(Source)}		3	mA
Output Current Sink	I _{IOUT(Sink)}		1	mA
Operating Ambient Temperature	T _A	Range K	-40 to 125	°C
Junction Temperature	T _J (max)		165	°C
Storage Temperature	T _{stg}		-65 to 170	°C

ISOLATION CHARACTERISTICS

Characteristic	Symbol	Notes	Rating	Unit
Dielectric Surge Strength Test Voltage	V _{SURGE}	Tested ±5 pulses at 2/minute in compliance to IEC 61000-4-5 1.2 µs (rise) / 50 µs (width).	6000	V
Dialogtria Strongth Tost Voltage*	V	Agency type-tested for 60 seconds per IEC/UL 60950-1 (2nd Edition).	3600	V _{RMS}
Dielectric Strength Test Voltage*	V _{ISO}	Agency type-tested for 60 seconds per UL 1577.	3000	V _{RMS}
Working Voltage for Basic Isolation	V	Maximum approved working voltage for basic (single) isolation	870	V _{PK} or VDC
Working voltage for basic isolation	V_{WVBI}	according to IEC/UL 60950-1 (2nd Edition).	616	V _{RMS}
Clearance	D _{CL}	Minimum distance through air from IP leads to signal leads.	7.5	mm
Creepage	D _{CR}	Minimum distance along package body from IP leads to signal leads.	7.5	mm

 $^{^{\}star}$ Production tested for 1 second at 3600 V_{RMS} in accordance with both UL 1577 and IEC/UL 60950-1 (edition 2).

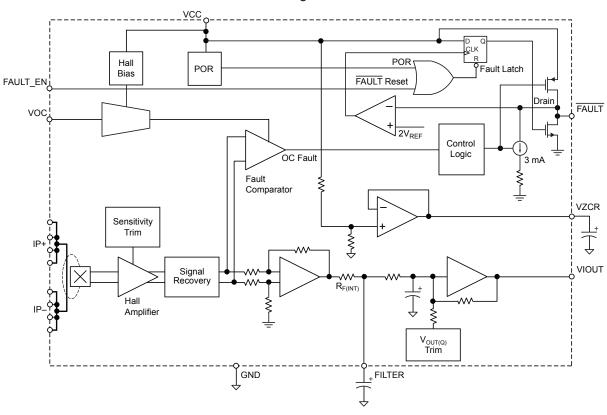
THERMAL CHARACTERISTICS

Characteristic	Symbol	Test Conditions	Value	Units
Package Thermal Resistance	$R_{ heta JA}$	When mounted on Allegro demo board with 1332 mm² (654 mm² on component side and 678 mm² on opposite side) of 2 oz. copper connected to the primary leadframe and with thermal vias connecting the copper layers. Performance is based on current flowing through the primary leadframe and includes the power consumed by the PCB.	17	°C/W



Functional Block Diagram

Latching Versions



Pinout Diagram

16 FAULT_EN IP+ 1 IP+ 2 15 VOC IP+ 3 14 VCC 13 FAULT IP+ 4 12 VIOUT IP- 5 11 FILTER IP- 6 10 VZCR IP- 7 IP-8 9 GND

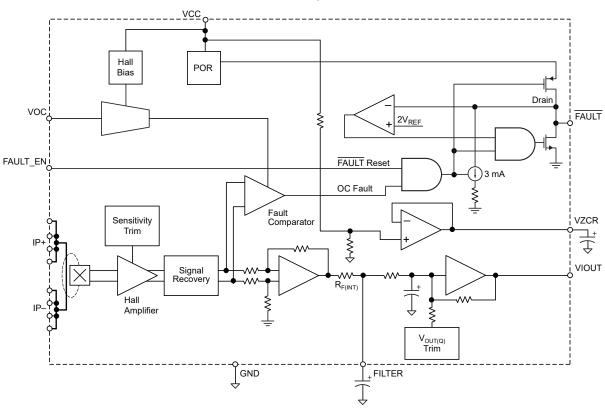
Terminal List, Latching Versions

Number	Name	Description
1,2,3,4	IP+	Sensed current copper conduction path pins. Terminals for current being sensed; fused internally, loop to IP– pins; unidirectional or bidirectional current flow.
5,6,7,8	IP-	Sensed current copper conduction path pins. Terminals for current being sensed; fused internally, loop to IP+ pins; unidirectional or bidirectional current flow.
9	GND	Device ground connection.
10	VZCR	Voltage Reference Output pin. Zero current (0 A) reference; output voltage on this pin scales with $V_{\rm CC}$. (Not a highly accurate reference.)
11	FILTER	Filter pin. Terminal for an external capacitor connected from this pin to GND to set the device bandwidth.
12	VIOUT	Analog Output pin. Output voltage on this pin is proportional to current flowing through the loop between the IP+ pins and IP– pins.
13	FAULT	Overcurrent Fault pin. When current flowing between IP+ pins and IP- pins exceeds the overcurrent fault threshold, this pin transitions to a logic low state.
14	VCC	Supply voltage.
15	VOC	Overcurrent Input pin. Analog input voltage on this pin sets the overcurrent fault threshold.
16	FAULT_EN	Enables overcurrent faulting when high. Resets FAULT when low.



Functional Block Diagram

Non-Latching Versions



Pinout Diagram

Terminal List, Non-Latching Version

Number	Name	Description
1,2,3,4	IP+	Sensed current copper conduction path pins. Terminals for current being sensed; fused internally, loop to IP– pins; unidirectional or bidirectional current flow.
5,6,7,8	IP-	Sensed current copper conduction path pins. Terminals for current being sensed; fused internally, loop to IP+ pins; unidirectional or bidirectional current flow.
9	GND	Device ground connection.
10	VZCR	Voltage Reference Output pin. Zero current (0 A) reference; output voltage on this pin scales with V_{CC} . (Not a highly accurate reference.)
11	FILTER	Filter pin. Terminal for an external capacitor connected from this pin to GND to set the device bandwidth.
12	VIOUT	Analog Output pin. Output voltage on this pin is proportional to current flowing through the loop between the IP+ pins and IP– pins.
13	FAULT	Overcurrent Fault pin. When current flowing between IP+ pins and IP- pins exceeds the overcurrent fault threshold, this pin transitions to a logic low state.
14	VCC	Supply voltage.
15	VOC	Overcurrent Input pin. Analog input voltage on this pin sets the overcurrent fault threshold.
16	FAULT_EN	Enables overcurrent faulting when high.



120 kHz Bandwidth, High-Voltage Isolation Current Sensor with Integrated Overcurrent Detection

COMMON OPERATING CHARACTERISTICS: Valid at $T_A = -40^{\circ}$ C to 125°C, $V_{CC} = 3.3$ V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
ELECTRICAL CHARACTERISTICS		•				
Supply Voltage	V _{CC}		3	_	3.6	V
Nominal Supply Voltage	V _{CCN}		-	3.3	_	V
Supply Current	I _{CC}	VIOUT open, FAULT pin high	-	9	11	mA
Output Capacitance Load	C _{LOAD}	VIOUT pin to GND	-	_	10	nF
Output Resistive Load	R _{LOAD}	VIOUT pin to GND	10	_	_	kΩ
Magnetic Coupling from Device Conductor to Hall Element	MC _{HALL}	Current flowing from IP+ to IP- pins	_	9.5	_	G/A
Internal Filter Resistance [1]	R _{F(INT)}		_	1.7	_	kΩ
Primary Conductor Resistance	R _{PRIMARY}	T _A = 25°C	_	1	_	mΩ
ANALOG OUTPUT SIGNAL CHARACTERIS						
Full Range Linearity ^[2]	E _{LIN}	$I_P = \pm I_{P0A}$	-0.75	±0.25	0.75	%
Symmetry [3]	E _{SYM}	$I_P = \pm I_{P0A}$	99.1	100	100.9	%
Bidirectional Quiescent Output	V _{OUT(QBI)}	I _P = 0 A, T _A = 25°C	_	V _{CC} × 0.5	_	V
Noise Density	I _{ND}	Input-referenced noise density; $T_A = 25^{\circ}C$, $C_L = 4.7 \text{ nF}$	_	400	_	μA /√(Hz)
Noise	I _N	Input referenced noise at 120 kHz Bandwidth; T _A = 25°C,C _L = 4.7 nF	_	170	-	mA _{rms}
TIMING PERFORMANCE CHARACTERIST	cs	•				'
VIOUT Signal Rise Time	t _r	T_A = 25°C, Swing I_P from 0 A to I_{P0A} , no capacitor on FILTER pin, 100 pF from VIOUT to GND	_	3	-	μs
VIOUT Signal Propagation Time	t _{PROP}	T _A = 25°C, no capacitor on FILTER pin, 100 pF from VIOUT to GND	_	1	-	μs
VIOUT Signal Response Time	t _{RESPONSE}	T_A = 25°C, Swing I _P from 0 A to I _{P0A} , no capacitor on FILTER pin, 100 pF from VIOUT to GND	_	4	-	μs
VIOUT Large Signal Bandwidth	f _{3dB}	-3 dB, Apply I _P such that V _{IOUT} = 1 V _{pk-pk} , no capacitor on FILTER pin, 100 pF from VIOUT to GND	_	120	-	kHz
Power-On Time	t _{PO}	Output reaches 90% of steady-state level, no capacitor on FILTER pin, T _A = 25°C	_	35	-	μs
OVERCURRENT CHARACTERISTICS						
Setting Voltage for Overcurrent Switch Point [4]	V _{OC}		V _{CC} × 0.25	_	V _{CC} × 0.4	V
Signal Noise at Overcurrent Comparator Input	I _{NCOMP}		_	±1	-	А
Overcurrent Fault Switchpoint Error [5][6]	E _{oc}	Switchpoint in V _{OC} safe operating area; assumes I _{NCOMP} = 0 A	_	±5	-	%
Overcurrent FAULT Pin Output Voltage	V _{FAULT}	1 mA sink current at FAULT pin	_	_	0.4	V
Fault Enable (FAULT_EN Pin) Input Low Voltage Threshold	V _{IL}		_	_	0.1×V _{CC}	V

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120 kHz Bandwidth, High-Voltage Isolation Current Sensor with Integrated Overcurrent Detection

COMMON OPERATING CHARACTERISTICS (continued): Valid at T_A = -40°C to 125°C, V_{CC} = 3.3 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
OVERCURRENT CHARACTERISTICS (cor	ntinued)	•				
Fault Enable (FAULT_EN Pin) Input High Voltage Threshold	V _{IH}		0.8 × V _{CC}	-	-	V
Fault Enable (FAULT_EN Pin) Input Resistance	R _{FEI}		-	1	_	ΜΩ
Fault Enable (FAULT_EN Pin) Delay ^[7]	t _{FED}	Set FAULT_EN to low, $V_{OC} = 0.25 \times V_{CC}$, $C_{OC} = 0$ F; then run a DC I_P exceeding the corresponding overcurrent threshold; then reset FAULT_EN from low to high and measure the delay from the rising edge of FAULT_EN to the falling edge of FAULT	-	15	-	μѕ
Fault Enable (FAULT_EN Pin) Delay (Non-Latching versions) [8]	t _{FED(NL)}	Set FAULT_EN to low, $V_{\rm OC}$ = 0.25 × $V_{\rm CC}$, $C_{\rm OC}$ = 0 F; then run a DC I _P exceeding the corresponding overcurrent threshold; then reset FAULT_EN from low to high and measure the delay from the rising edge of FAULT_EN to the falling edge of FAULT	-	150	-	ns
Overcurrent Fault Response Time	t _{oc}	FAULT_EN set to high for a minimum of 20 μ s before the overcurrent event; switchpoint set at V _{OC} = 0.25 × V _{CC} ; apply a current step to I _P with amplitude equal to 1.5 x V _{OC} / Sens; delay from I _P exceeding overcurrent fault threshold to V _{FAULT} < 0.4 V, without external C _{OC} capacitor	-	2	-	μѕ
Undercurrent Fault Response Time (Non-Latching versions)	t _{UC}	FAULT_EN set to high for a minimum of 20 μs before the undercurrent event; switchpoint set at V_{OC} = 0.25 × V_{CC} ; delay from I_P falling below the overcurrent fault threshold to $V_{\overline{FAULT}}$ > 0.8 × V_{CC} , without external C_{OC} capacitor, R_{PU} = 330 kΩ	-	3	-	μѕ
Overcurrent Fault Reset Delay	t _{OCR}	Time from $V_{FAULTEN} < V_{IL}$ to $V_{FAULT} > 0.8 \times V_{CC}$, $R_{PU} = 330 \text{ k}\Omega$	_	500	_	ns
Overcurrent Fault Reset Hold Time	t _{осн}	Time from V _{FAULTEN} pin < V _{IL} to reset of fault latch; see Functional Block Diagram	_	250	_	ns
Overcurrent Input Pin Resistance	R _{OC}	T _A = 25°C, VOC pin to GND	2	_		ΜΩ

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120 kHz Bandwidth, High-Voltage Isolation Current Sensor with Integrated Overcurrent Detection

COMMON OPERATING CHARACTERISTICS (continued): Valid at T_A = -40°C to 125°C, V_{CC} = 3.3 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units		
VOLTAGE REFERENCE CHARACTERISTICS								
Voltage Reference Output	V _{ZCR}	T _A = 25 °C (Not a highly accurate reference)	0.48 × V _{CC}	0.5 × V _{CC}	0.52×V _{CC}	V		
Voltage Deference Output Load Current	I _{ZCR}	Source current	3	_	-	mA		
Voltage Reference Output Load Current		Sink current	50	_	_	μΑ		
Voltage Reference Output Drift	ΔV_{ZCR}		_	±10	_	mV		

 $^{^{[1]}}R_{F(INT)}$ forms an RC circuit via the FILTER pin.



^[2] This parameter can drift by as much as 0.8% over the lifetime of this product.

^[3] This parameter can drift by as much as 1% over the lifetime of this product.

^[4] See page 9 on how to set overcurrent fault switchpoint.

^[5] Switchpoint can be lower at the expense of switchpoint accuracy.

^[6] This error specification does not include the effect of noise. See the I_{NCOMP} specification in order to factor in the additional influence of noise on the fault switchpoint.

^[7] Fault Enable Delay is designed to avoid false tripping of an Overcurrent (OC) fault at power-up. A 15 µs (typical) delay will always be needed, every time FAULT EN is raised from low to high, before the device is ready for responding to any overcurrent event.

^[8] During power-up, this delay is 15 µs in order to avoid false tripping of an Overcurrent (OC) fault.

120 kHz Bandwidth, High-Voltage Isolation Current Sensor with Integrated Overcurrent Detection

PERFORMANCE CHARACTERISTICS: T_A Range K, valid at T_A = -40°C to 125°C, V_{CC} = 3.3 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
X6BB CHARACTERISTICS	3					
Optimized Accuracy Range [1]	I _{POA}		-7.5	_	7.5	Α
Linear Sensing Range	I _R		-14	_	14	Α
Noise [2]	V _{NOISE(rms)}	$T_A = 25$ °C, Sens = 100 mV/A, $C_f = 0$, $C_{LOAD} = 4.7$ nF, R_{LOAD} open	_	3.0	_	mV
	Sens	$I_{p} = 6.5 \text{ A}, T_{A} = 25^{\circ}\text{C}$	_	100	_	mV/A
Sensitivity [3]		I _P = 6.5 A, T _A = 25°C to 125°C	_	100	-	mV/A
		$I_P = 6.5 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$	_	101	_	mV/A
Electrical Offset Voltage		I _P = 0 A, T _A = 25°C	_	±11	_	mV
Variation Relative to	V _{OE}	I _P = 0 A, T _A = 25°C to 125°C	_	±11	_	mV
V _{OUT(QBI)} ^[4]		$I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$	_	±35	_	mV
Total Output Francis	_	Over full scale of I _{POA} , I _P applied for 5 ms, T _A = 25°C to 125°C	_	±2.2	_	%
Total Output Error [5]	E _{TOT}	Over full scale of I_{POA} , I_{P} applied for 5 ms, T_{A} = -40° C to 25°C	_	±6	_	%

^[1] Although the device is accurate over the entire linear range, the device is programmed for maximum accuracy over the range defined by I_{POA}. The reason for this is that in many applications, such as motor control, the start-up current of the motor is approximately three times higher than the running current.

PERFORMANCE CHARACTERISTICS: T_A Range K, valid at T_A = -40°C to 125°C, V_{CC} = 3.3 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
X12CB CHARACTERISTIC	S					
Optimized Accuracy Range [1]	I _{POA}		-12.5	_	12.5	Α
Linear Sensing Range	I _R		-37.5	_	37.5	Α
Noise [2]	V _{NOISE(rms)}	T_A = 25°C, Sens = 37 mV/A, C_f = 0, C_{LOAD} = 4.7 nF, R_{LOAD} open	_	1.0	_	mV
	Sens	I _P = 12.5 A, T _A = 25°C	_	37.1	_	mV/A
Sensitivity [3]		I _P = 12.5 A, T _A = 25°C to 125°C	_	37.0	_	mV/A
		$I_P = 12.5 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$	_	37.7	_	mV/A
Electrical Offset Voltage		I _P = 0 A, T _A = 25°C	_	±6	-	mV
Variation Relative to	V _{OE}	I _P = 0 A, T _A = 25°C to 125°C	_	±11	-	mV
V _{OUT(QBI)} ^[4]		$I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$	_	±21	_	mV
Total Output Francis	_	Over full scale of I _{POA} , I _P applied for 5 ms, T _A = 25°C to 125°C	_	±2.7	_	%
Total Output Error [5]	E _{TOT}	Over full scale of I_{POA} , I_{P} applied for 5 ms, T_{A} = -40°C to 25°C	_	±6.5	_	%

^[1] Although the device is accurate over the entire linear range, the device is programmed for maximum accuracy over the range defined by I_{POA}. The reason for this is that in many applications, such as motor control, the start-up current of the motor is approximately three times higher than the running current.



^[2] V_{pk-pk} noise (6 sigma noise) is equal to 6 × V_{NOISE(rms)}. Lower noise levels than this can be achieved by using C_f for applications requiring narrower bandwidth. See Characteristic Performance page for graphs of noise versus C_f and bandwidth versus C_f.

^[3] This parameter can drift by as much as 2.4% over the lifetime of this product.

^[4] This parameter can drift by as much as 13 mV over the lifetime of this product.

^[5] This parameter can drift by as much as 2.5% over the lifetime of this product.

^[3] This parameter can drift by as much as 2.4% over the lifetime of this product.

^[4] This parameter can drift by as much as 13 mV over the lifetime of this product.

^[5] This parameter can drift by as much as 2.5% over the lifetime of this product.

120 kHz Bandwidth, High-Voltage Isolation Current Sensor with Integrated Overcurrent Detection

PERFORMANCE CHARACTERISTICS: T_A Range K, valid at T_A = -40°C to 125°C, V_{CC} = 3.3 V, unless otherwise specified

Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units		
X25CB CHARACTERISTICS								
Optimized Accuracy Range [1]	I _{POA}		-25	_	25	Α		
Linear Sensing Range	I _R		-75	_	75	Α		
Noise [2]	V _{NOISE(rms)}	$T_A = 25$ °C, Sens = 18.5 mV/A, $C_f = 0$, $C_{LOAD} = 4.7$ nF, R_{LOAD} open	_	0.5	_	mV		
Sensitivity ^[3]	Sens	I _P = 25 A, T _A = 25°C	_	18.6	_	mV/A		
		I _P = 25 A, T _A = 25°C to 125°C	_	18.5	_	mV/A		
		$I_p = 25 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$	_	18.9	_	mV/A		
Electrical Offset Voltage Variation Relative to V _{OUT(QBI)} [4]	V _{OE}	$I_{P} = 0 \text{ A}, T_{A} = 25^{\circ}\text{C}$	_	±5	_	mV		
		I _P = 0 A, T _A = 25°C to 125°C	_	±13	-	mV		
		$I_P = 0 \text{ A}, T_A = -40^{\circ}\text{C to } 25^{\circ}\text{C}$	_	±18	-	mV		
Total Output Error [5]	E _{TOT}	Over full scale of I _{POA} , I _P applied for 5 ms, T _A = 25°C to 125°C	_	±2.9	_	%		
		Over full scale of I_{POA} , I_{P} applied for 5 ms, T_{A} = -40 °C to 25°C	_	±5.2	_	%		

^[1] Although the device is accurate over the entire linear range, the device is programmed for maximum accuracy over the range defined by I_{POA}. The reason for this is that in many applications, such as motor control, the start-up current of the motor is approximately three times higher than the running current.



 $^{^{[2]}}$ V_{pk-pk} noise (6 sigma noise) is equal to 6 × $V_{NOISE(rms)}$. Lower noise levels than this can be achieved by using C_f for applications requiring narrower bandwidth. See Characteristic Performance page for graphs of noise versus C_f and bandwidth versus C_f .

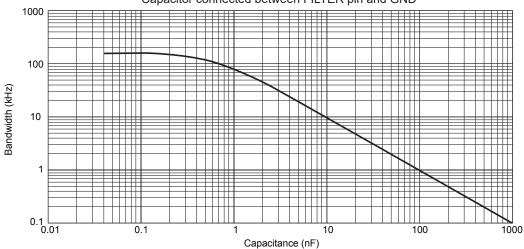
^[3] This parameter can drift by as much as 2.4% over the lifetime of this product.

^[4] This parameter can drift by as much as 13 mV over the lifetime of this product.

^[5] This parameter can drift by as much as 2.5% over the lifetime of this product.

CHARACTERISTIC PERFORMANCE

ACS716 Bandwidth versus External Capacitor Value, C_F Capacitor connected between FILTER pin and GND



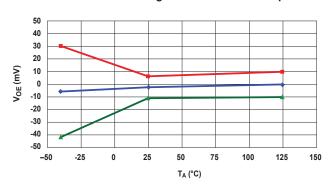


CHARACTERISTIC PERFORMANCE DATA

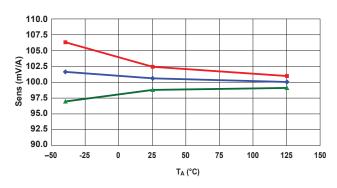
Data taken using the ACS716-6BB

Accuracy Data

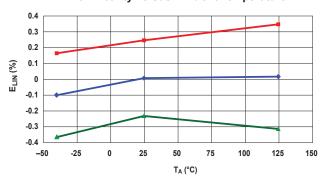
Electrical Offset Voltage versus Ambient Temperature



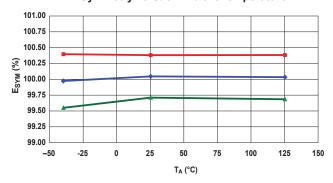
Sensitivity versus Ambient Temperature



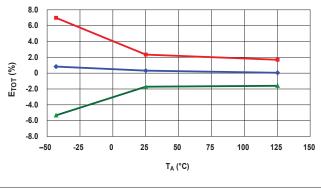
Nonlinearity versus Ambient Temperature

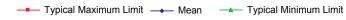


Symmetry versus Ambient Temperature



Total Output Error versus Ambient Temperature





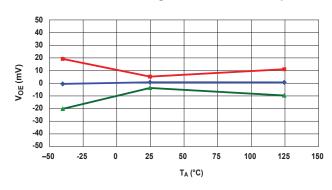


CHARACTERISTIC PERFORMANCE DATA

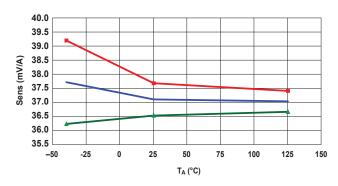
Data taken using the ACS716-12CB

Accuracy Data

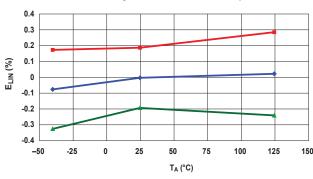
Electrical Offset Voltage versus Ambient Temperature



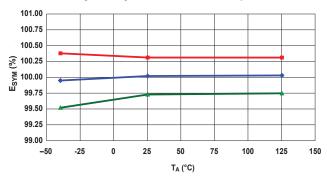
Sensitivity versus Ambient Temperature



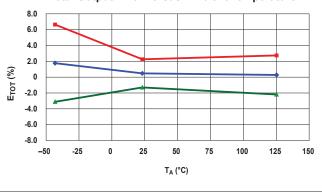
Nonlinearity versus Ambient Temperature



Symmetry versus Ambient Temperature



Total Output Error versus Ambient Temperature



— Typical Maximum Limit → Mean Typical Minimum Limit

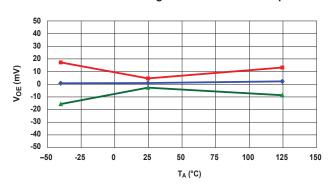


CHARACTERISTIC PERFORMANCE DATA

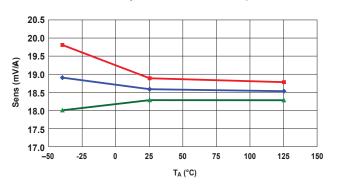
Data taken using the ACS716-25CB

Accuracy Data

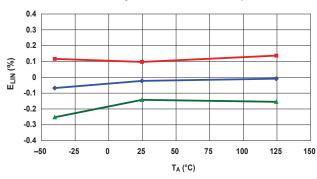




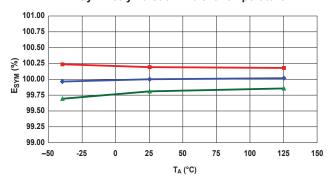
Sensitivity versus Ambient Temperature



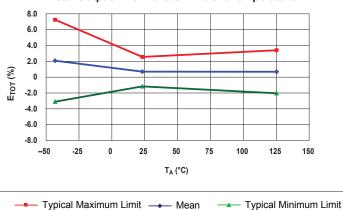
Nonlinearity versus Ambient Temperature



Symmetry versus Ambient Temperature



Total Output Error versus Ambient Temperature





SETTING OVERCURRENT FAULT SWITCH POINT

Setting 12CB and 25CB Versions

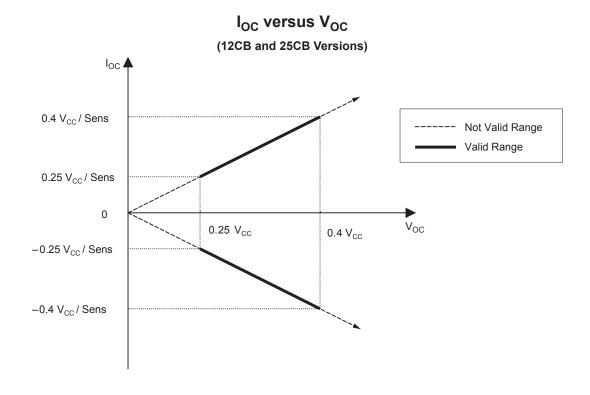
The V_{OC} needed for setting the overcurrent fault switchpoint can be calculated as follows:

$$V_{\rm OC} = {\rm Sens} \times |I_{\rm OC}|$$
,

where V_{OC} is in mV, Sens in mV/A, and I_{OC} (overcurrent fault switchpoint) in A.

 $|\:\text{Ioc}\:|$ is the overcurrent fault switchpoint for a bidirectional (AC) current, which means a bidirectional sensor will have two symmetrical overcurrent fault switchpoints, $\:+\text{I}_{OC}\:$ and $\:-\text{I}_{OC}\:$.

See the following graph for I_{OC} and V_{OC} ranges.



Example: For ACS716KLATR-25CB-T, if required overcurrent fault switchpoint is 50 A, and V_{CC} = 3.3 V, then the required V_{OC} can be calculated as follows:

$$V_{OC}$$
 = Sens × I_{OC} = 18.5 × 50 = 925 (mV)



Setting 6BB Versions

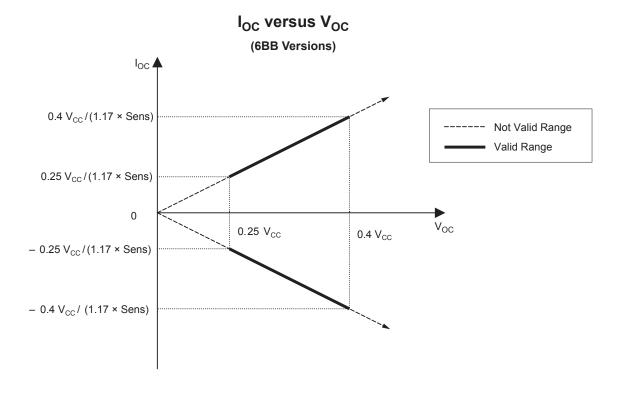
The V_{OC} needed for setting the overcurrent fault switchpoint can be calculated as follows:

$$V_{\rm OC} = 1.17 \times {\rm Sens} \times |I_{\rm OC}|$$
,

where V_{OC} is in mV, Sens in mV/A, and I_{OC} (overcurrent fault switchpoint) in A.

| Ioc | is the overcurrent fault switchpoint for a bidirectional (AC) current, which means a bidirectional sensor will have two symmetrical overcurrent fault switchpoints, $+I_{OC}$ and $-I_{OC}$.

See the following graph for I_{OC} and V_{OC} ranges.



Example: For ACS716KLATR-6BB-T, if required overcurrent fault switchpoint is 10 A, and V_{CC} = 3.3 V, then the required V_{OC} can be calculated as follows:

$$V_{OC}$$
 = 1.17 × Sens × I_{OC} = 1.17 × 100 × 10 = 1170 (mV)



FUNCTIONAL DESCRIPTION (Latching Versions)

Overcurrent Fault Operation

The primary concern with high-speed fault detection is that noise may cause false tripping. Various applications have or need to be able to ignore certain faults that are due to switching noise or other parasitic phenomena, which are application dependant. The problem with simply trying to filter out this noise in the main signal path is that in high-speed applications, with asymmetric noise, the act of filtering introduces an error into the measurement. To get around this issue, and allow the user to prevent the fault signal from being latched by noise, a circuit was designed to slew the \overline{FAULT} pin voltage based on the value of the capacitor from that pin to ground. Once the voltage on the pin falls below 2 V, as established by an internal reference, the fault output is latched and pulled to ground quickly with an internal N-channel MOSFET.

Fault Walkthrough

The following walkthrough references various sections and attributes in the figure below. This figure shows different fault set/reset scenarios and how they relate to the voltages on the FAULT pin, FAULT_EN pin, and the internal Overcurrent (OC) Fault node, which is invisible to the customer.

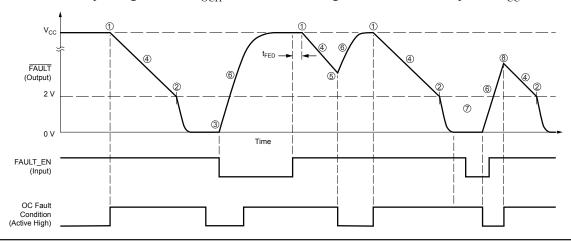
- 1. Because the device is enabled (FAULT_EN is high for a minimum period of time, the Fault Enable Delay, t_{FED}, 15 μs typical) and there is an OC fault condition, the device FAULT pin starts discharging.
- 2. When the FAULT pin voltage reaches approximately 2 V, the fault is latched, and an internal NMOS device pulls the FAULT pin voltage to approximately 0 V. The rate at which the FAULT pin slews downward (see [4] in the figure) is dependent on the external capacitor, C_{OC}, on the FAULT pin.
- 3. When the FAULT_EN pin is brought low, the FAULT pin starts resetting if no OC fault condition exists, and if FAULT EN is low for a time period greater than t_{OCH}. The

- internal NMOS pull-down turns off and an internal PMOS pull-up turns on (see [7] if the OC fault condition still exists).
- 4. The slope, and thus the delay to latch the fault is controlled by the capacitor, C_{OC}, placed on the FAULT pin to ground. During this portion of the fault (when the FAULT pin is between V_{CC} and 2 V), there is a 3 mA constant current sink, which discharges C_{OC}. The length of the fault delay, t, is equal to:

$$t = \frac{C_{\text{oc}} \times (V_{\text{CC}} - 2V)}{3 \text{ mA}} \tag{1}$$

where V_{CC} is the device power supply voltage in volts, t is in seconds and C_{OC} is in Farads. This formula is valid for R_{PU} equal to or greater than 330 k Ω . For lower-value resistors, the current flowing through the R_{PU} resistor during a fault event, I_{PU} , will be larger. Therefore, the current discharging the capacitor would be 3 mA – I_{PU} and equation 1 may not be valid.

- 5. The FAULT pin did not reach the 2 V latch point before the OC fault condition cleared. Because of this, the fixed 3 mA current sink turns off, and the internal PMOS pull-up turns on to recharge C_{OC} through the FAULT pin.
- 6. This curve shows V_{CC} charging external capacitor C_{OC} through the internal PMOS pull-up. The slope is determined by C_{OC} .
- 7. When the FAULT_EN pin is brought low, if the fault condition still exists, the latched FAULT pin will be pulled low by the internal 3mA current source. When fault condition is removed then the Fault pin charges as shown in step 6.
- 8. At this point there is a fault condition, and the part is enabled before the \overline{FAULT} pin can charge to V_{CC} . This shortens the user-set delay, so the fault is latched earlier. The new delay time can be calculated by equation 1, after substituting the voltage seen on the \overline{FAULT} pin for V_{CC} .





FUNCTIONAL DESCRIPTION (Non-Latching Versions)

Overcurrent Fault Operation

The primary concern with high-speed fault detection is that noise may cause false tripping. Various applications have or need to be able to ignore certain faults that are due to switching noise or other parasitic phenomena, which are application dependant. The problem with simply trying to filter out this noise in the main signal path is that in high-speed applications, with asymmetric noise, the act of filtering introduces an error into the measurement. To get around this issue, and allow the user to prevent the fault signal from going low due to noise, a circuit was designed to slew the FAULT pin voltage based on the value of the capacitor from that pin to ground. Once the voltage on the pin falls below 2 V, as established by an internal reference, the fault output is pulled to ground quickly with an internal N-channel MOSFET.

Fault Walkthrough

The following walkthrough references various sections and attributes in the figure below. This figure shows different fault set/reset scenarios and how they relate to the voltages on the FAULT pin, FAULT_EN pin, and the internal Overcurrent (OC) Fault node, which is invisible to the customer.

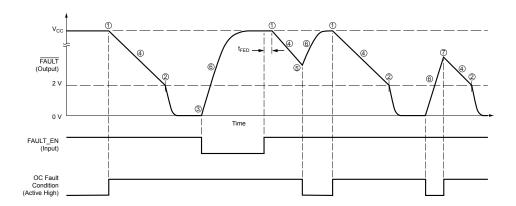
- Because the device is enabled (FAULT_EN is high for a minimum period of time, the Fault Enable Delay, t_{FED}, and there is an OC fault condition, the device FAULT pin starts discharging.
- 2. When the FAULT pin voltage reaches approximately 2 V, an internal NMOS device pulls the FAULT pin voltage to approximately 0 V. The rate at which the FAULT pin slews downward (see [4] in the figure) is dependent on the external capacitor, C_{OC}, on the FAULT pin.
- 3. When the FAULT_EN pin is brought low, the FAULT pin starts resetting if FAULT EN is low for a time period greater

- than $t_{\rm OCH}$. The internal NMOS pull-down turns off and an internal PMOS pull-up turns on.
- 4. The slope, and thus the delay to pull the fault low is controlled by the capacitor, C_{OC} , placed on the \overline{FAULT} pin to ground. During this portion of the fault (when the \overline{FAULT} pin is between V_{CC} and 2 V), there is a 3 mA constant current sink, which discharges C_{OC} . The length of the fault delay, t, is equal to:

$$t = \frac{C_{\text{oc}} \times (V_{\text{CC}} - 2 \text{ V})}{3 \text{ mA}}$$
 (2)

where V_{CC} is the device power supply voltage in volts, t is in seconds and C_{OC} is in Farads. This formula is valid for R_{PU} equal to or greater than 330 k Ω . For lower-value resistors, the current flowing through the R_{PU} resistor during a fault event, I_{PU} , will be larger. Therefore, the current discharging the capacitor would be 3 mA – I_{PU} and equation 1 may not be valid.

- 5. The \overline{FAULT} pin did not reach the 2 V latch point before the OC fault condition cleared. Because of this, the fixed 3 mA current sink turns off, and the internal PMOS pull-up turns on to recharge C_{OC} through the \overline{FAULT} pin.
- 6. This curve shows V_{CC} charging external capacitor C_{OC} through the internal PMOS pull-up. The slope is determined by C_{OC} .
- 7. At this point there is a fault condition, and the part is enabled before the \overline{FAULT} pin can charge to V_{CC} . This shortens the user-set delay, so the fault gets pulled low earlier. The new delay time can be calculated by equation 1, after substituting the voltage seen on the \overline{FAULT} pin for V_{CC} .





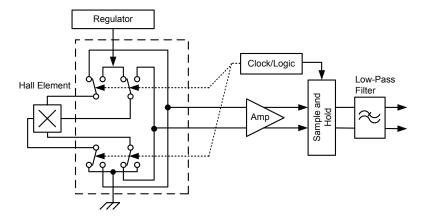
120 kHz Bandwidth, High-Voltage Isolation Current Sensor with Integrated Overcurrent Detection

Chopper Stabilization Technique

Chopper stabilization is an innovative circuit technique that is used to minimize the offset voltage of a Hall element and an associated on-chip amplifier. Allegro has a chopper stabilization technique that nearly eliminates Hall IC output drift induced by temperature or package stress effects. This offset reduction technique is based on a signal modulation-demodulation process. Modulation is used to separate the undesired DC offset signal from the magnetically induced signal in the frequency domain. Then, using a low-pass filter, the modulated DC offset is suppressed while the magnetically induced signal passes through the filter. As a result of this chopper stabilization approach, the

output voltage from the Hall IC is desensitized to the effects of temperature and mechanical stress. This technique produces devices that have an extremely stable electrical offset voltage, are immune to thermal stress, and have precise recoverability after temperature cycling.

This technique is made possible through the use of a BiCMOS process that allows the use of low-offset and low-noise amplifiers in combination with high-density logic integration and sample-and-hold circuits.



Concept of Chopper Stabilization Technique



120 kHz Bandwidth, High-Voltage Isolation Current Sensor with Integrated Overcurrent Detection

Definitions of Accuracy Characteristics

Sensitivity (Sens). The change in sensor output in response to a 1 A change through the primary conductor. The sensitivity is the product of the magnetic circuit sensitivity (G/A) and the linear IC amplifier gain (mV/G). The linear IC amplifier gain is programmed at the factory to optimize the sensitivity (mV/A) for the full-scale current of the device.

Noise (V_{NOISE}). The product of the linear IC amplifier gain (mV/G) and the noise floor for the Allegro Hall-effect linear IC. The noise floor is derived from the thermal and shot noise observed in Hall elements. Dividing the noise (mV) by the sensitivity (mV/A) provides the smallest current that the device is able to resolve.

Linearity (E_{LIN}). The degree to which the voltage output from the sensor varies in direct proportion to the primary current through its full-scale amplitude. Nonlinearity in the output can be attributed to the saturation of the flux concentrator approaching the full-scale current. The following equation is used to derive the linearity:

$$100 \left\{ 1 - \left[\begin{array}{c} V_{\text{IOUT_full-scale amperes}} - V_{\text{IOUT(Q)}} \\ \hline 2 \left(V_{\text{IOUT_1/2 full-scale amperes}} - V_{\text{IOUT(Q)}} \right) \end{array} \right] \right\}$$

where $V_{\rm IOUT_full\text{-}scale\ amperes}$ = the output voltage (V) when the sensed current approximates full-scale $\pm I_{\rm P}$.

Symmetry (E_{SYM}). The degree to which the absolute voltage output from the sensor varies in proportion to either a positive or negative full-scale primary current. The following formula is used to derive symmetry:

$$100 \left(\frac{V_{\text{IOUT}} + \text{full-scale amperes} - V_{\text{IOUT}(Q)}}{V_{\text{IOUT}(Q)} - V_{\text{IOUT}} - \text{full-scale amperes}} \right)$$

Quiescent output voltage ($V_{IOUT(Q)}$). The output of the sensor when the primary current is zero. For a unipolar supply voltage, it nominally remains at $0.5 \times V_{CC}$. For example, in the case of a bidirectional output device, $V_{CC} = 3.3$ V translates into $V_{IOUT(Q)} = 1.65$ V. Variation in $V_{IOUT(Q)}$ can be attributed to the resolution of the Allegro linear IC quiescent voltage trim and thermal drift.

Electrical offset voltage (V_{OE}). The deviation of the device output from its ideal quiescent voltage due to nonmagnetic causes. To convert this voltage to amperes, divide by the device sensitivity, Sens.

Accuracy (E_{TOT}). The accuracy represents the maximum deviation of the actual output from its ideal value. This is also known as the total ouput error. The accuracy is illustrated graphically in the output voltage versus current chart at right. Note that error is directly measured during final test at Allegro.

Accuracy is divided into four areas:

- **0** A at 25°C. Accuracy of sensing zero current flow at 25°C, without the effects of temperature.
- **0** A over ∆ temperature. Accuracy of sensing zero current flow including temperature effects.
- Full-scale current at 25°C. Accuracy of sensing the full-scale current at 25°C, without the effects of temperature.
- Full-scale current over ∆ temperature. Accuracy of sensing full-scale current flow including temperature effects.

Ratiometry. The ratiometric feature means that its 0 A output, $V_{IOUT(Q)}$, (nominally equal to $V_{CC}/2$) and sensitivity, Sens, are proportional to its supply voltage, V_{CC} . The following formula is used to derive the ratiometric change in 0 A output voltage, $\Delta V_{IOUT(Q)RAT}$ (%).

$$100 \left(\frac{V_{\text{IOUT(Q)VCC}} / V_{\text{IOUT(Q)3.3V}}}{V_{\text{CC}} / 3.3 \text{ (V)}} \right)$$

The ratiometric change in sensitivity, $\Delta Sens_{RAT}$ (%), is defined as:

$$100 \left(\frac{Sens_{VCC} / Sens_{3.3V}}{V_{CC} / 3.3 (V)} \right)$$

Output Voltage versus Sensed Current Accuracy at 0 A and at Full-Scale Current

Accuracy
Over ΔTemp erature

Accuracy
Over ΔTemp erature

Accuracy
Over ΔTemp erature

Accuracy
Ip(min)

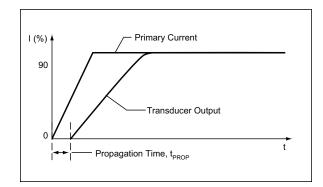
Full Scale
Ip(max)



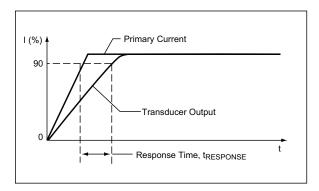
Decreasing V_{IOUT}(V

Definitions of Dynamic Response Characteristics

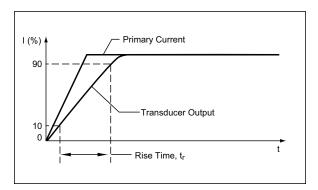
Propagation delay (t_{PROP}). The time required for the sensor output to reflect a change in the primary current signal. Propagation delay is attributed to inductive loading within the linear IC package, as well as in the inductive loop formed by the primary conductor geometry. Propagation delay can be considered as a fixed-time offset and may be compensated.



Response time ($t_{RESPONSE}$). The time interval between a) when the primary current signal reaches 90% of its final value, and b) when the sensor reaches 90% of its output corresponding to the applied current.



Rise time (t_r). The time interval between a) when the sensor reaches 10% of its full-scale value, and b) when it reaches 90% of its full-scale value. The rise time to a step response is used to derive the bandwidth of the current sensor, in which $f(-3 \text{ dB}) = 0.35/t_r$. Both t_r and $t_{RESPONSE}$ are detrimentally affected by eddy current losses observed in the conductive IC ground plane.



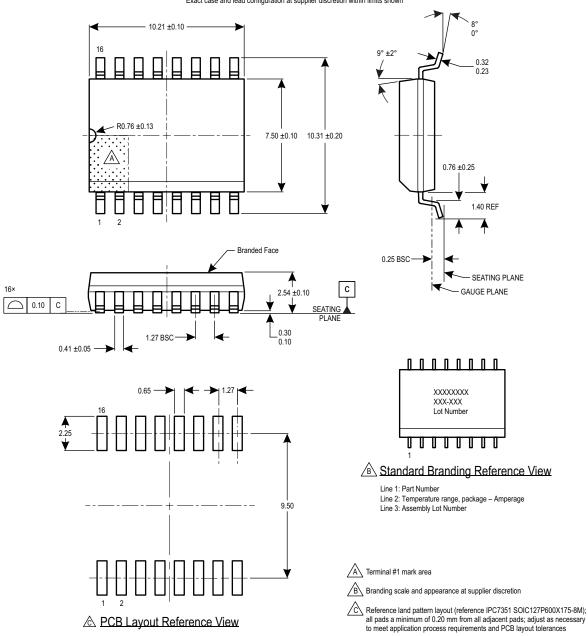


Package LA, 16-Pin SOICW

For Reference Only – Not for Tooling Use

(Reference Allegro DWG-0000388, Rev. 1 and JEDEC MS-013AA) NOT TO SCALE Dimensions in millimeters

Dimensions exclusive of mold flash, gate burrs, and dambar protrusions Exact case and lead configuration at supplier discretion within limits shown





120 kHz Bandwidth, High-Voltage Isolation Current Sensor with Integrated Overcurrent Detection

Revision History

Number	Date	Description
3	January 15, 2013	Update I _R , I _P , add non-latching versions, update to current terminology
4	August 19, 2015	Added certificate number under UL stamp on page 1; updated Isolation Characteristics table.
5	June 5, 2017	Updated product status
6	August 31, 2017	Added Dielectric Surge Strength Test Voltage to Isolation Characteristics table (p. 3), and Noise and Noise Density characteristics to Common Operating Characteristics table (p. 6).
7	November 13, 2017 Corrected typo in Dielectric Surge Strength Test Voltage notes of Isolation Characteristics table	
8	December 6, 2018	Updated UL certificate number and minor editorial updates
9	February 1, 2019	Updated product status to Pre-End-of-Life
10	February 3, 2020	Updated product status and minor editorial updates
11	July 29, 2021	Corrected buffered output on non-latching functional block diagram (page 5)
12	August 9, 2022	Updated package drawing (page 22)
13	March 12, 2025	Changed product status to not for new design (cover sheet).

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